



Elettra Sincrotrone Trieste



Elettra  
Sincrotrone  
Trieste

# *Status of the diffraction beamlines at Elettra*



Elettra  
Sincrotrone  
Trieste

# Elettra – Sincrotrone Trieste



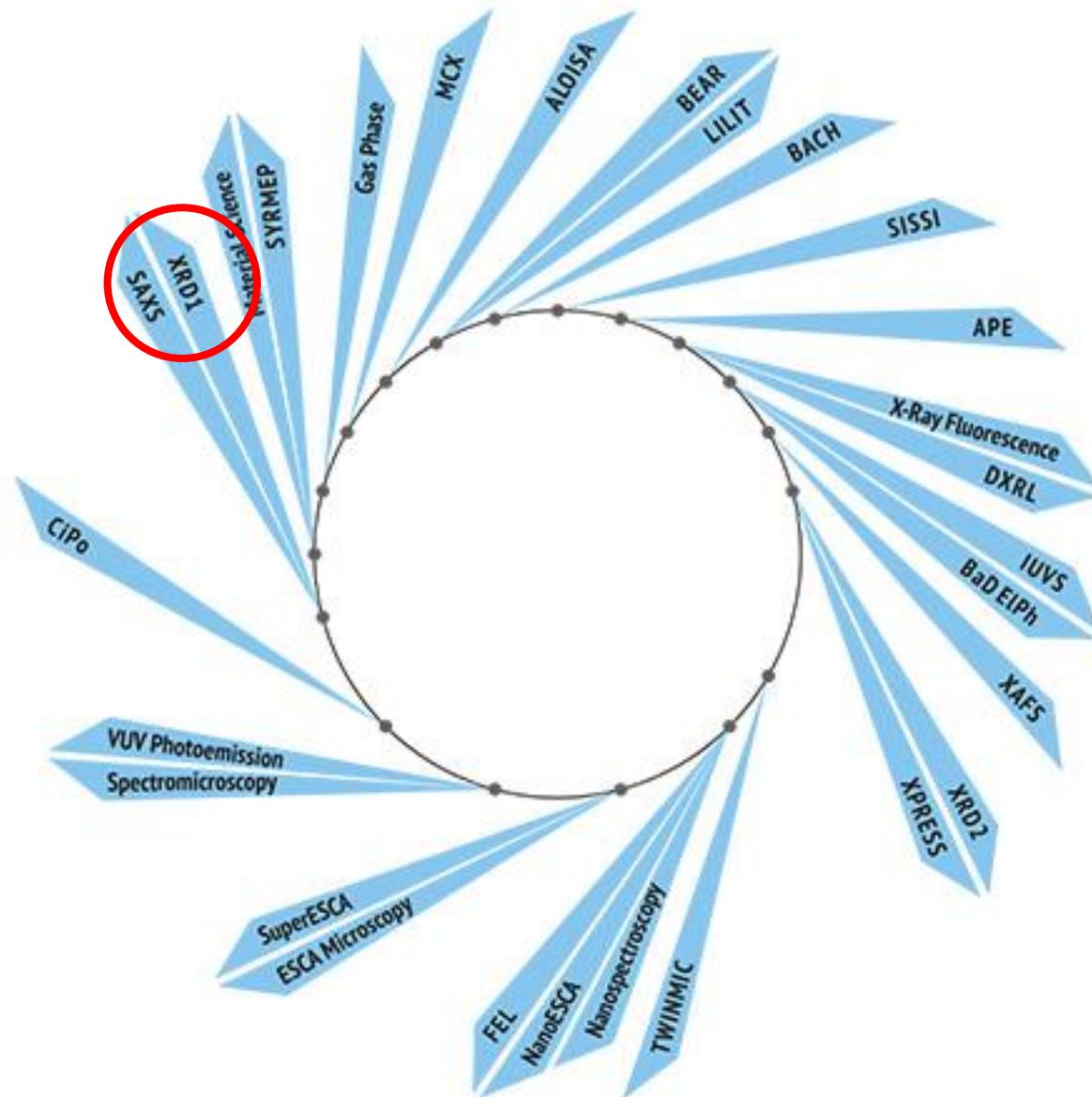


Elettra  
Sincrotrone  
Trieste

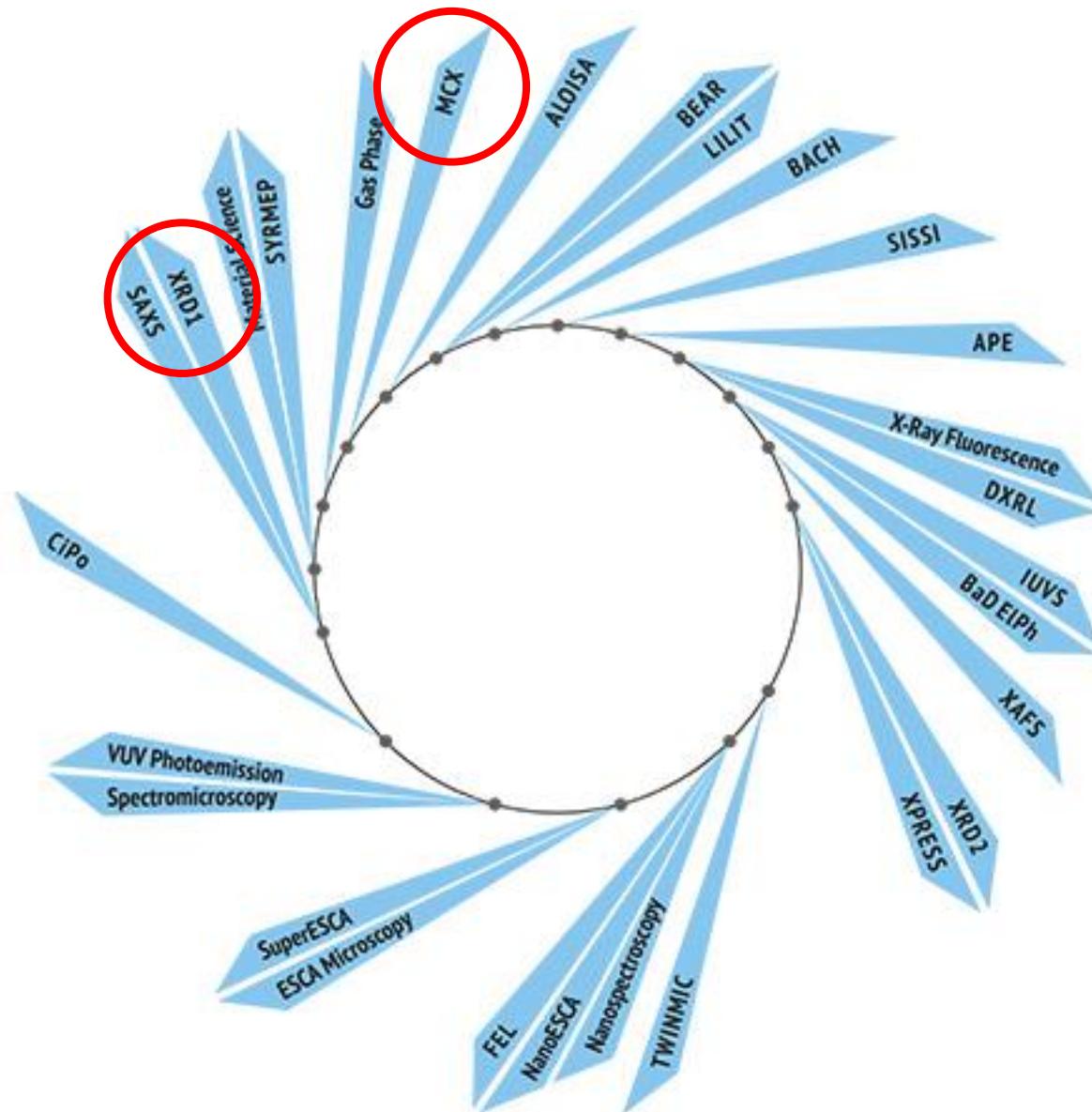
# Elettra – Sincrotrone Trieste



# Diffraction beamlines at Elettra

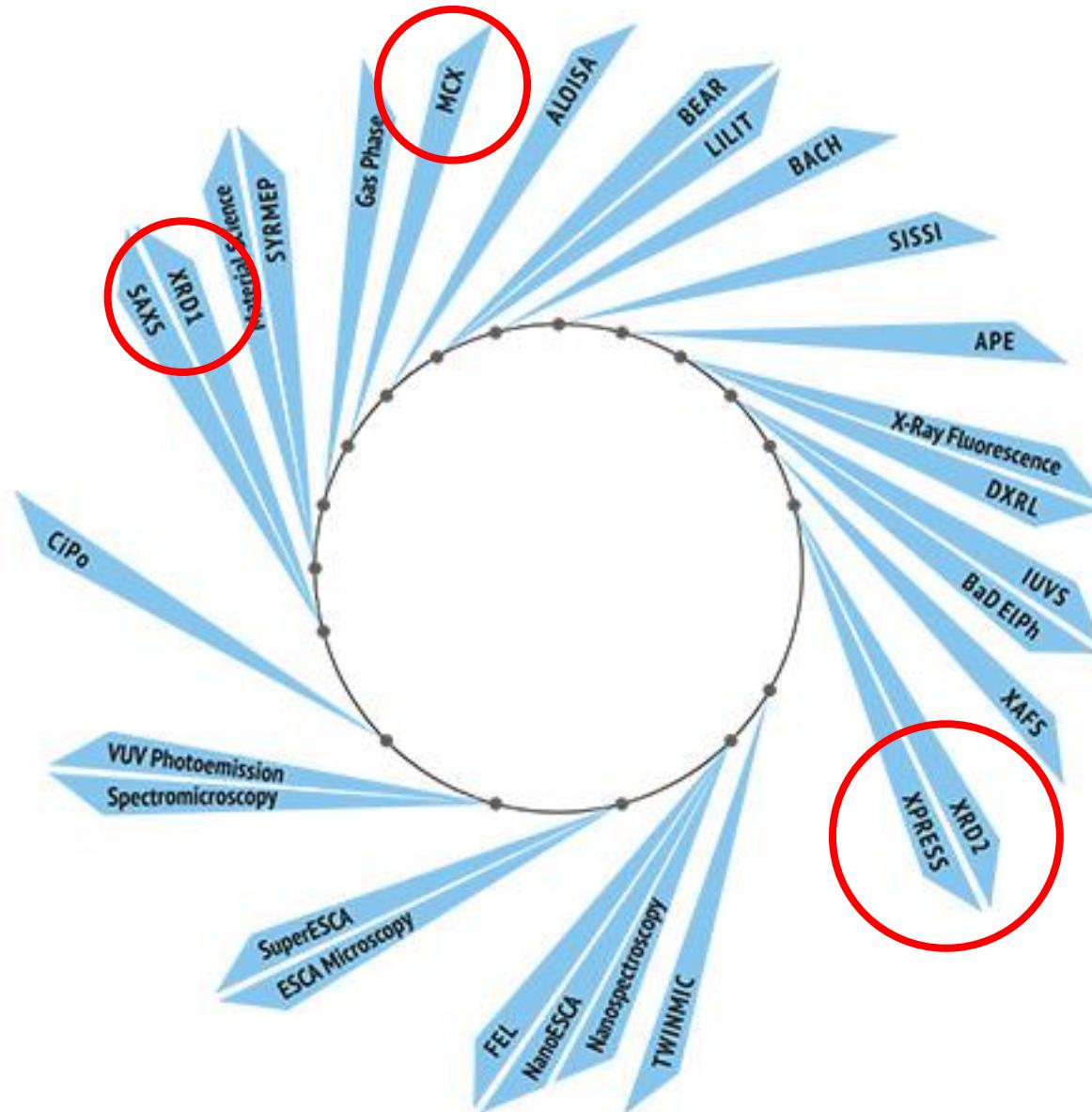


# Diffraction beamlines at Elettra



- XRD1 (1997)
- MCX (2007)

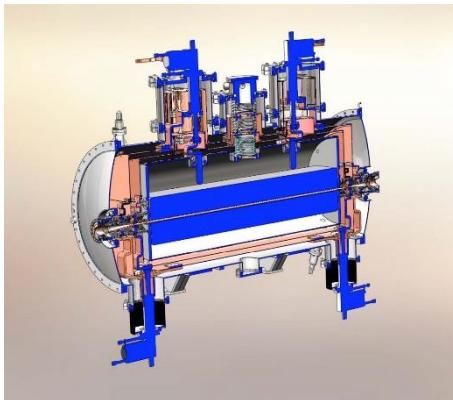
# Diffraction beamlines at Elettra



- XRD1 (1997)
- MCX (2007)
- Xpress (2016)
- XRD2 (2018)

## Beamline

Source: superconducting wiggler  
**Fully tunable** 8-20 KeV (35 KeV)  
Optimized for SeMet  
Native beam 300 um x 100 um



# XRD2 – Macromolecular Crystallography

## Diffractometer

MD2 → kappa  
Apertures (um)  
20, 50, 75, 100

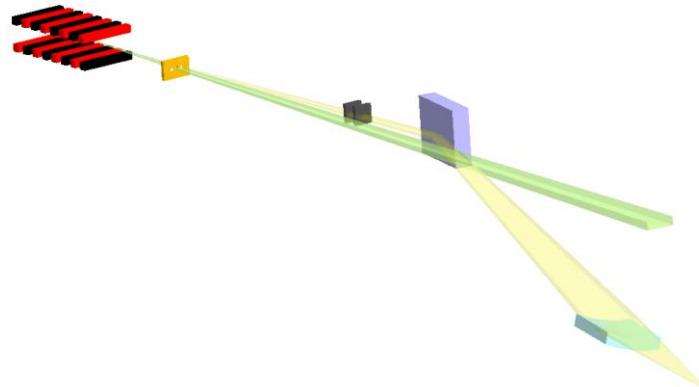
**Detector** Pilatus 6M  
**Shutterless**



**SampleChanger**  
**UNIPUCKS automation**  
Capacity 188 samples  
Dryer , lid, barcode



# XPress – High pressure diffraction

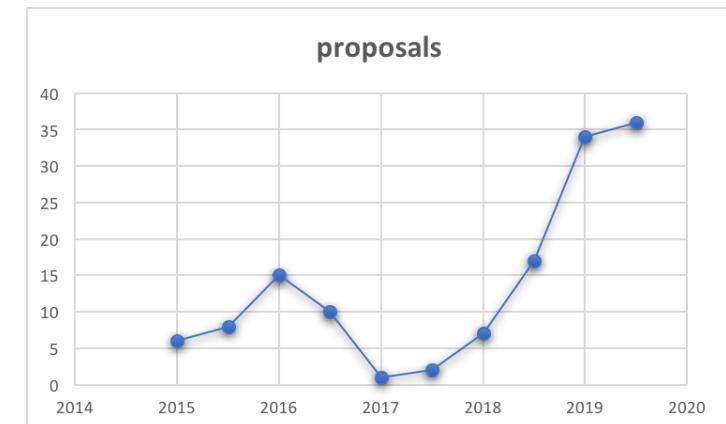
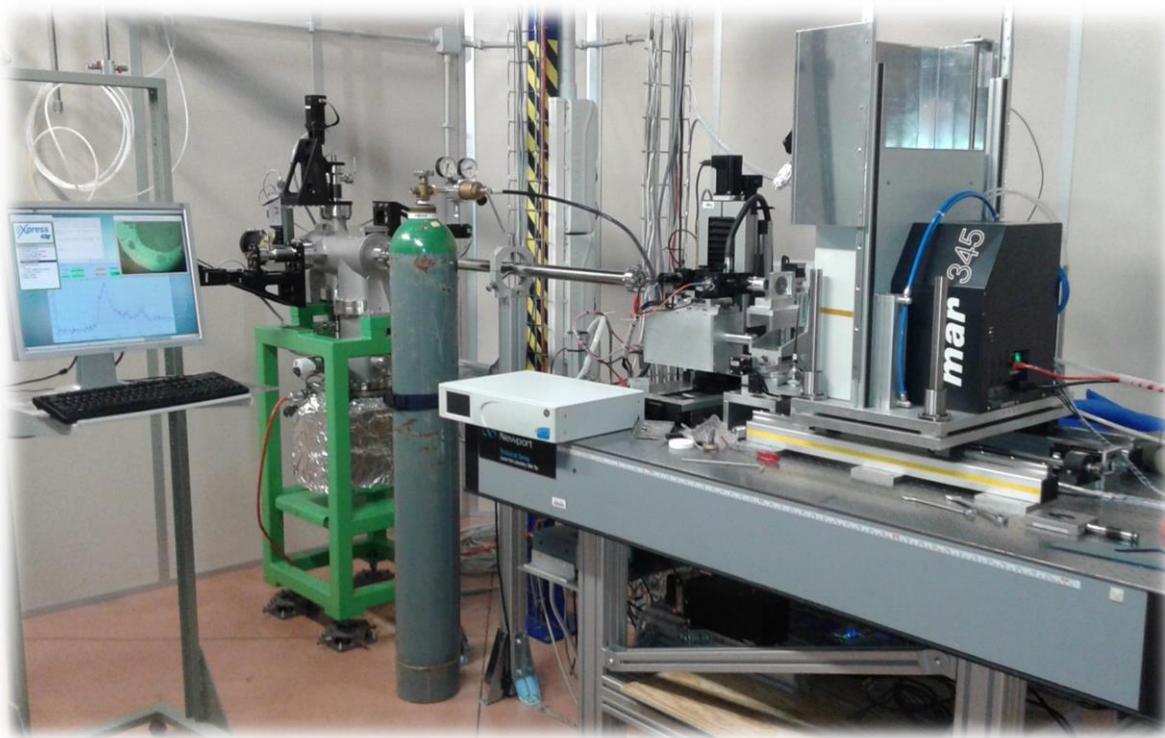


X-ray Energy 25 keV

Acceptance  $500 \times 120 \mu\text{rad}^2$

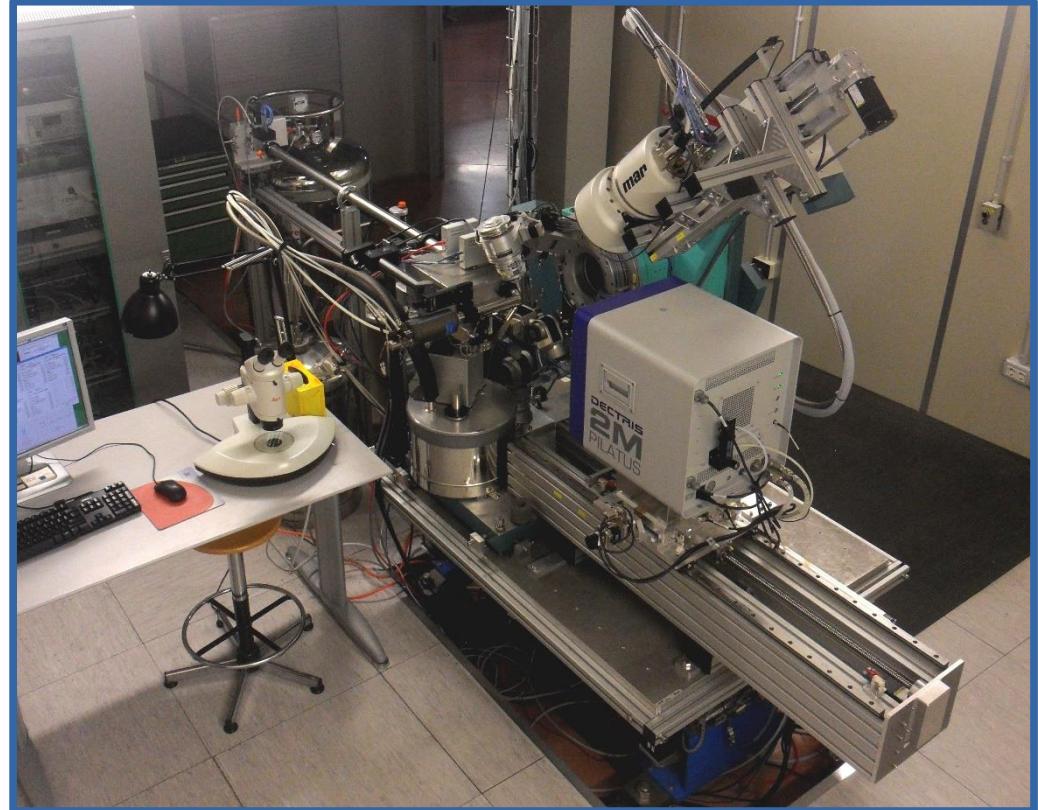
Flux in  $80 \times 80 \mu\text{m}^2$  aperture at sample:

**$10^{11} \text{ ph/s}$  @ 2.4 GeV, 100mA**



# XRD1 – General purpose diffraction

- Wiggler as source ( $5 \cdot 10^{12}$  ph/s)
- Wide spectrum 4-21.5 keV
- Beam size: 200 $\mu$ m – 30 $\mu$ m
- Huber k-geometry goniometer
- Spine compliant robotic arm for automatic sample mounting, 50 samples capacity (ESRF puck)
- Large single photon counting area detector (Dectris 2M)
- 9mm<sup>2</sup> fluorescence detector

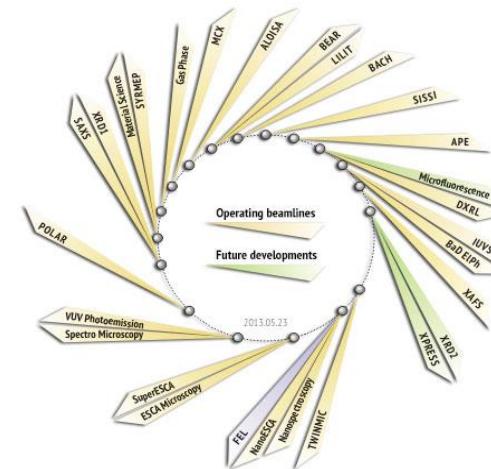


- At the present mainly used for: (i) single crystal for molecular structural solution (small molecules, supramolecular chemistry), (ii) grazing incidence diffraction (in-plane and out-of-plane), (iii) material science (phase transitions)

# MCX – Powder diffraction

- The Materials

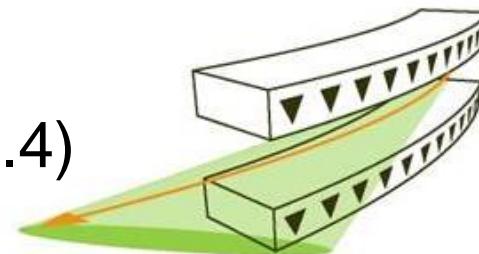
Characterization by X-ray diffraction (MCX) beamline allows to perform a wide range of non-single crystal diffraction experiments: grazing angle diffraction and reflectivity, residual stress and texture analysis, phase identification and structural studies and kinetic studies



# MCX - Optical scheme

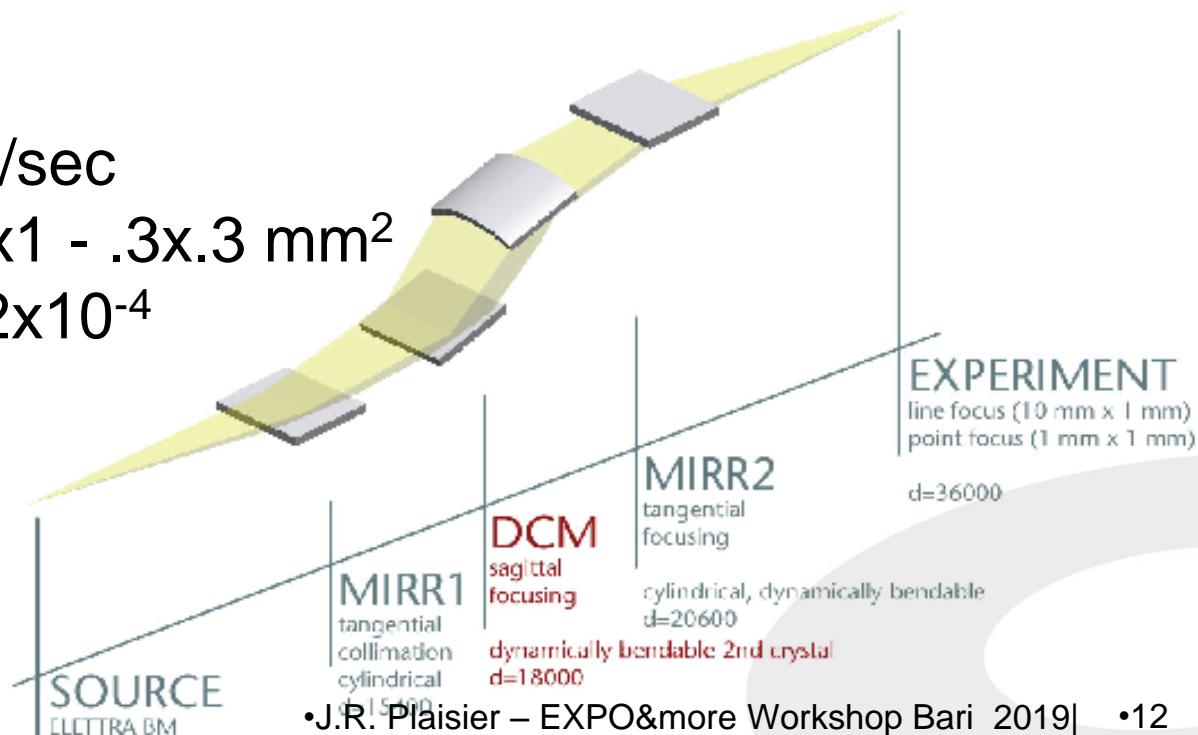
## Light Source:

- Bending magnet
- Critical energy : 3.2keV (2.0) , 5.5keV (2.4)



## X-rays at sample:

- Energy range : 6-22 keV
- Photon flux :  $10^{11}$  photons/sec
- Beam size at sample : 10x1 - .3x.3 mm<sup>2</sup>
- Energy resolution :  $\Delta E/E 2 \times 10^{-4}$



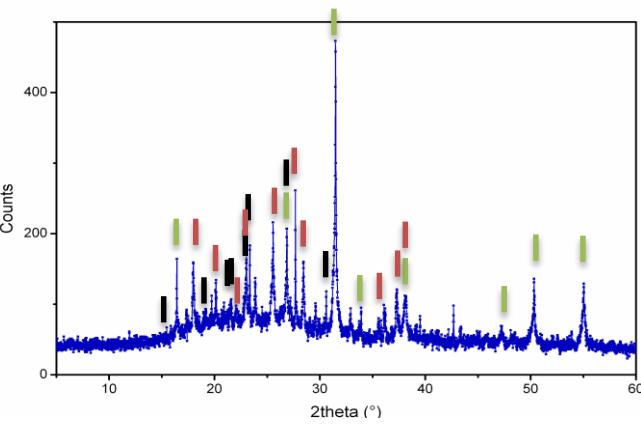
# MCX - Experimental station

- Huber 4 circle diffractometer (.0001° precision in  $2\theta$ )
- Analyzer crystal / scintillator detection system or CCD
- Transmission geometry, reflection geometry, grazing incidence diffraction
- Temperature control from 100 K to 1273 K
- Fluorescence detector



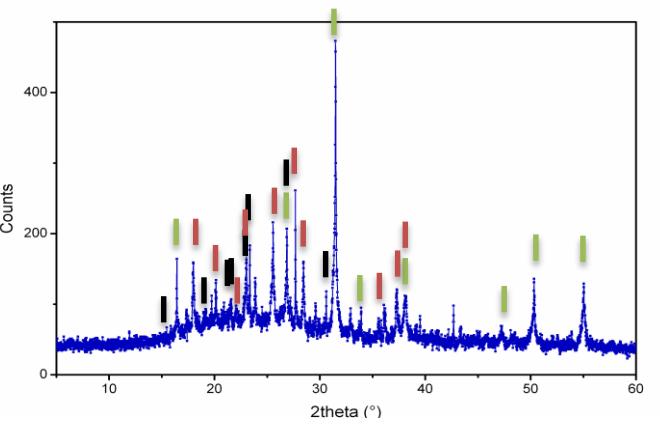
# Diffraction experiments at MCX

## Phase Identification

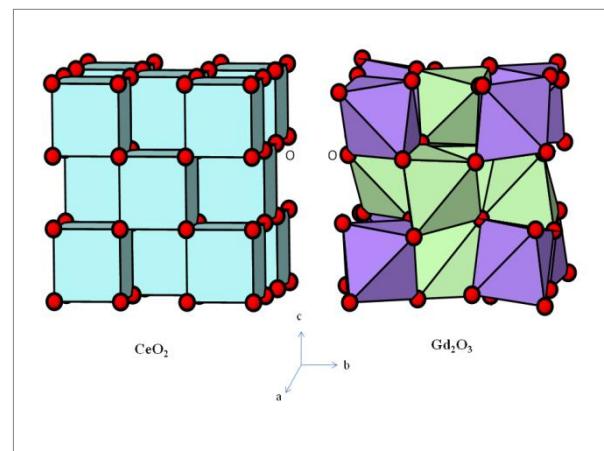
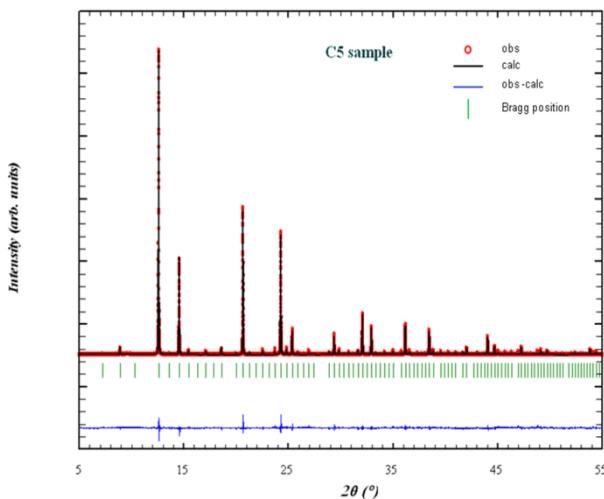


# Diffraction experiments at MCX

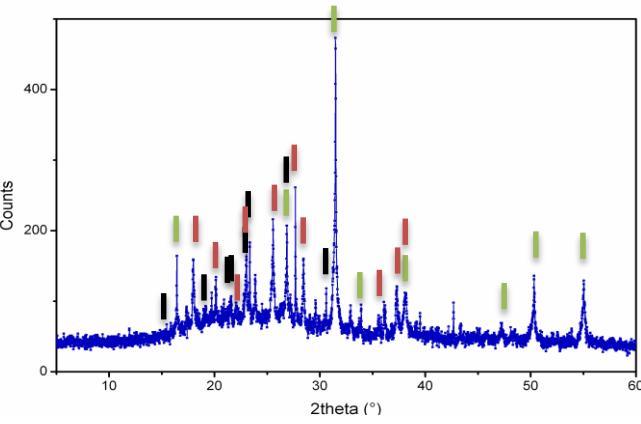
## Phase Identification



## Structure Determination

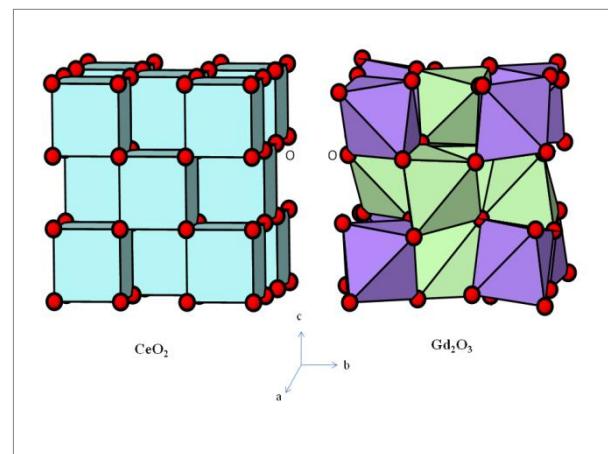
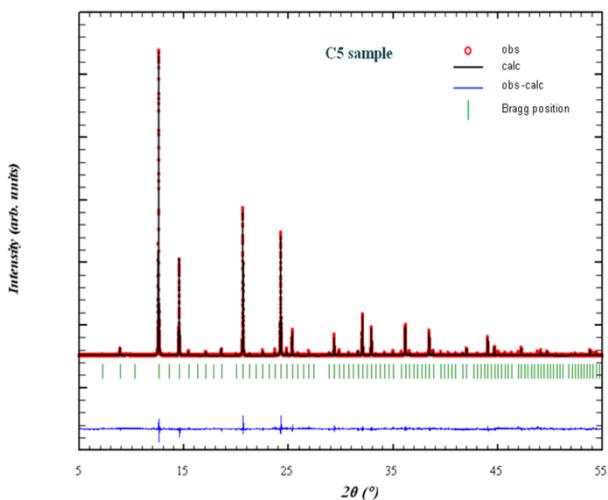


## Phase Identification

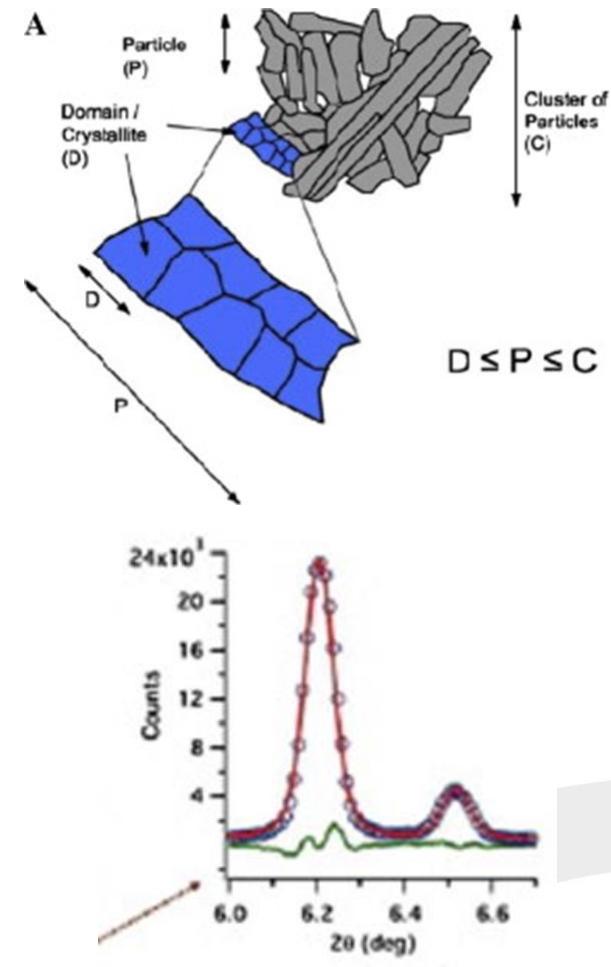


# Diffraction experiments at MCX

## Structure Determination

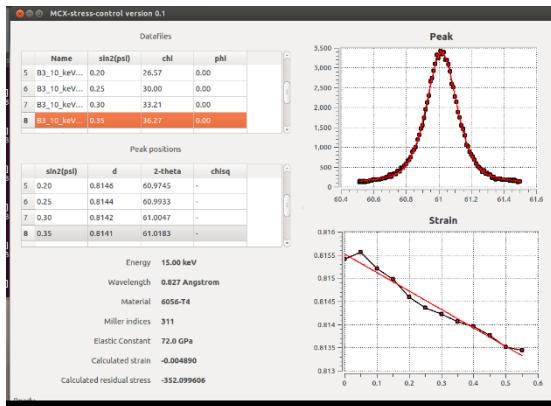
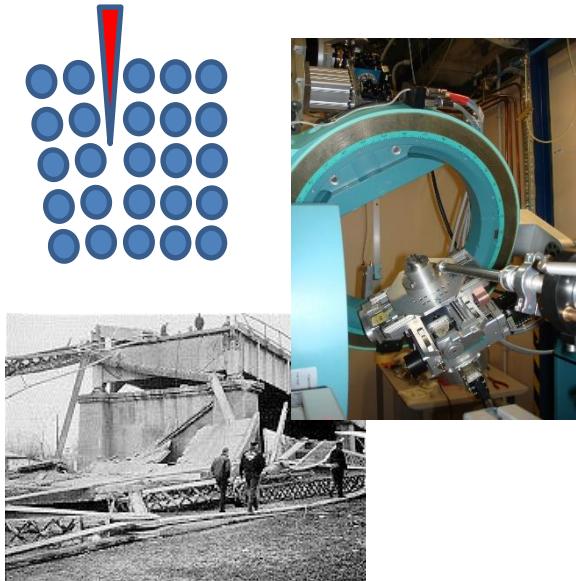


## Line Profile Analysis

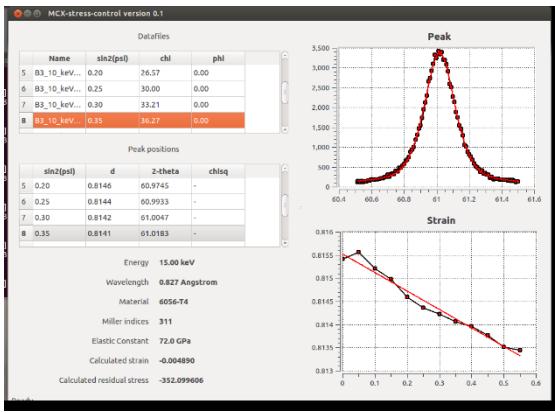
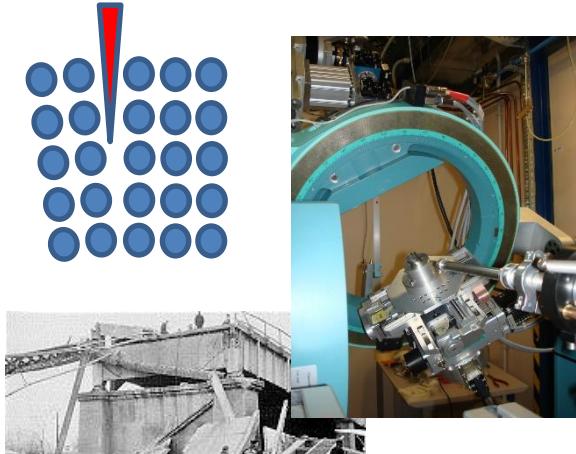


# Diffraction experiments at MCX

## Residual Stress Analysis

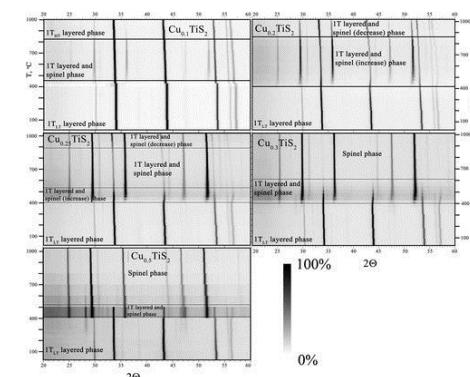
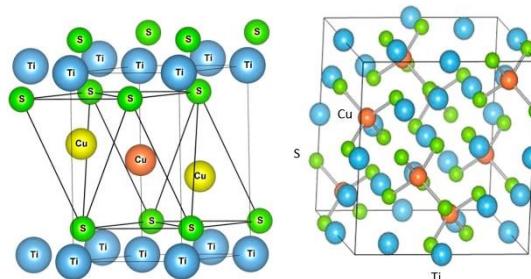
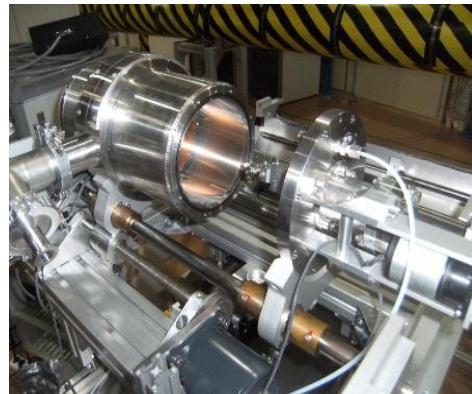


## Residual Stress Analysis

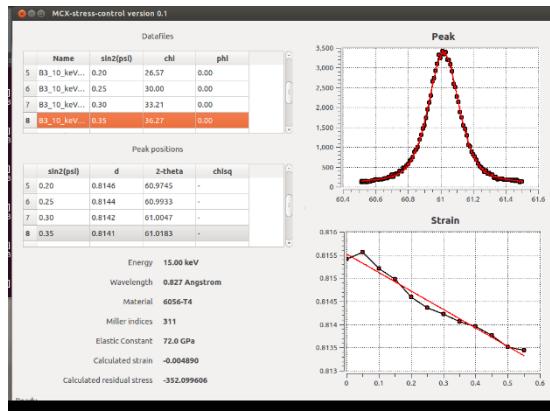
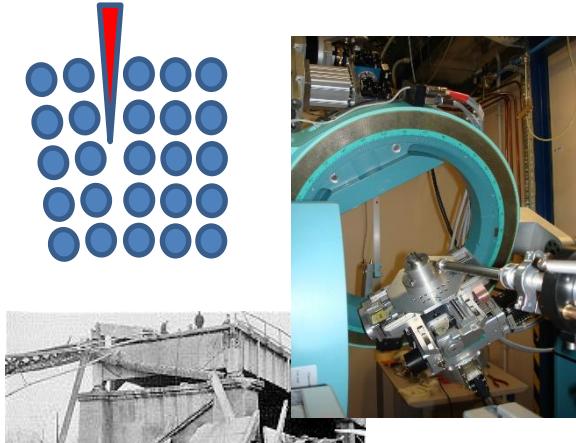


# Diffraction experiments at MCX

## Non ambient conditions

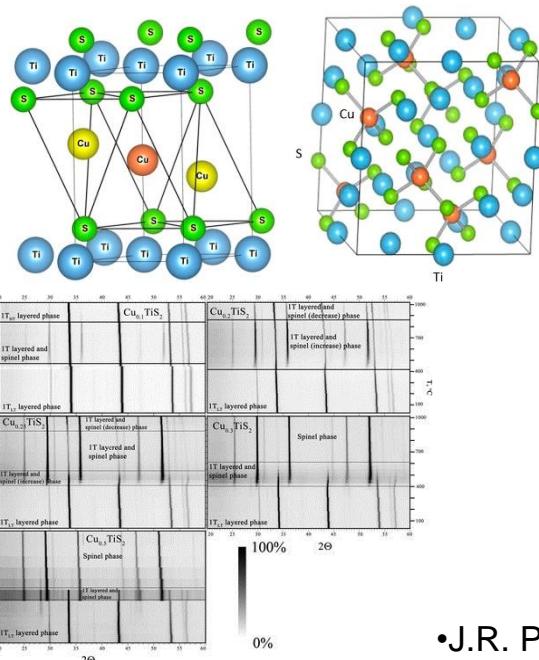


## Residual Stress Analysis

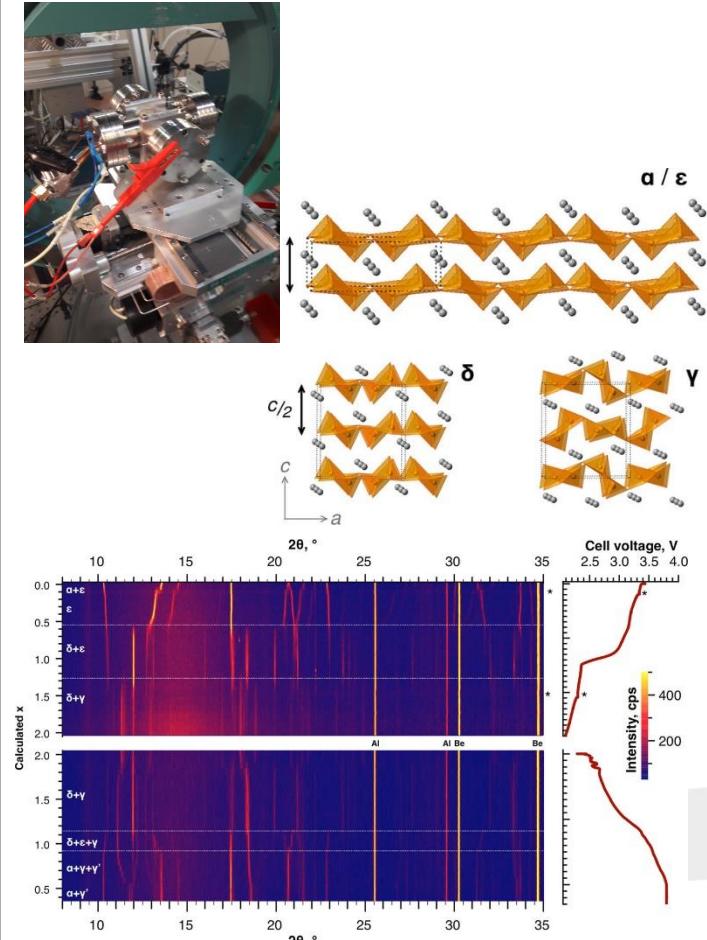


# Diffraction experiments at MCX

## Non ambient conditions



## Operando

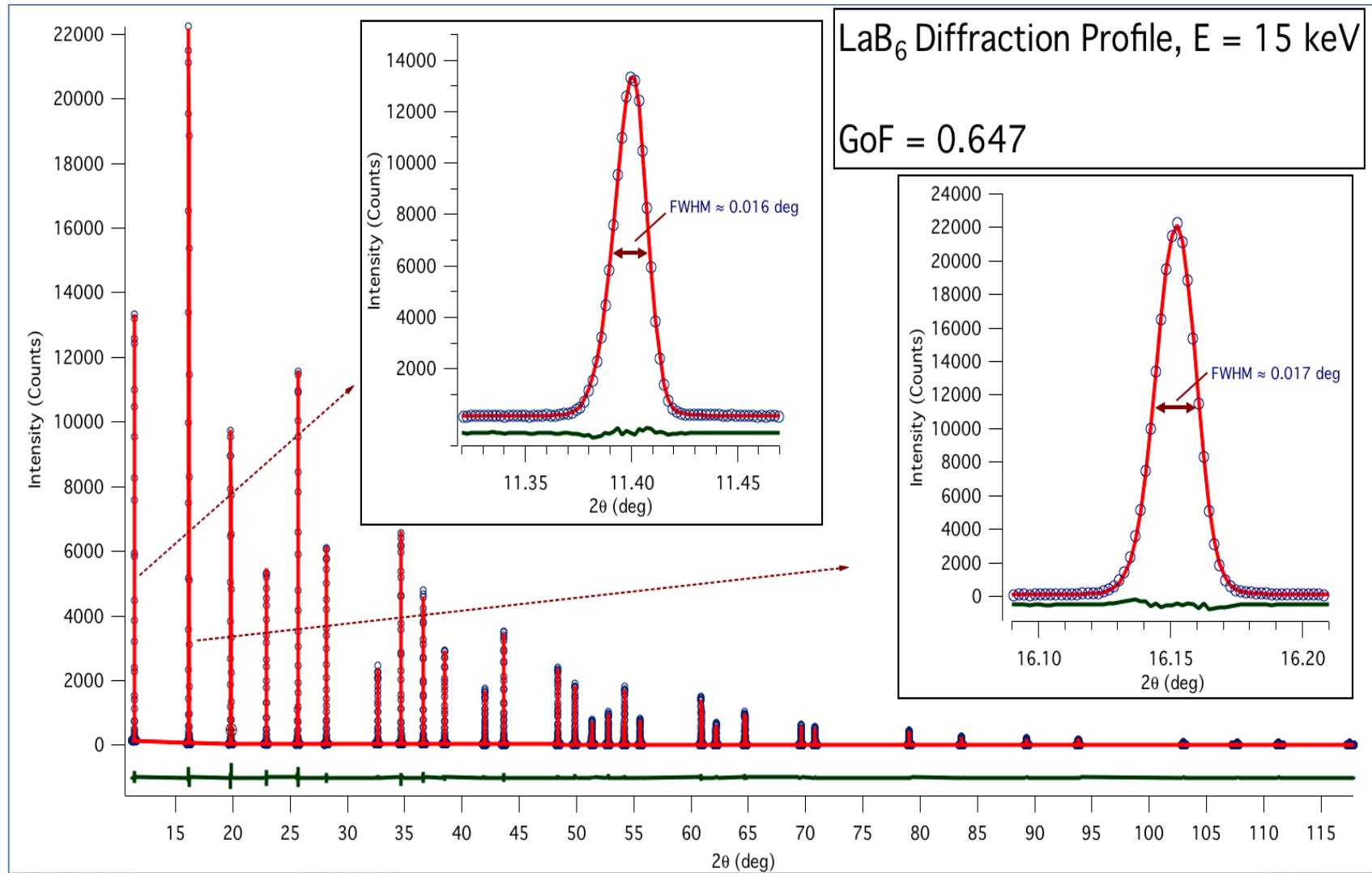




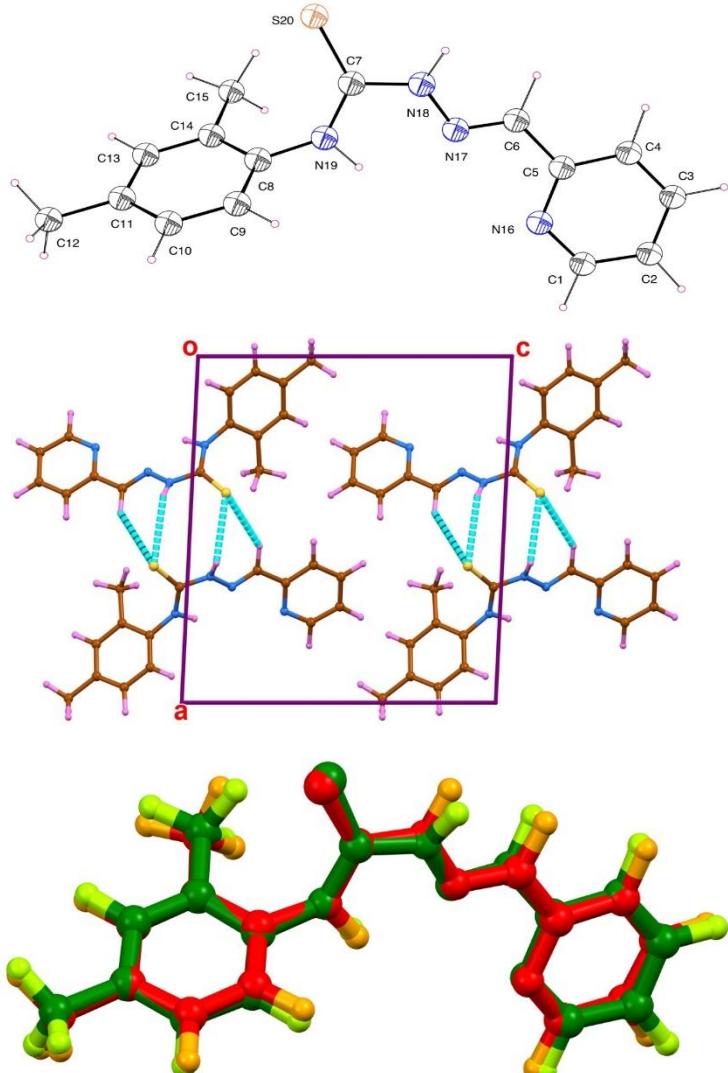
Elettra  
Sincrotrone  
Trieste

# MCX and EXPO?

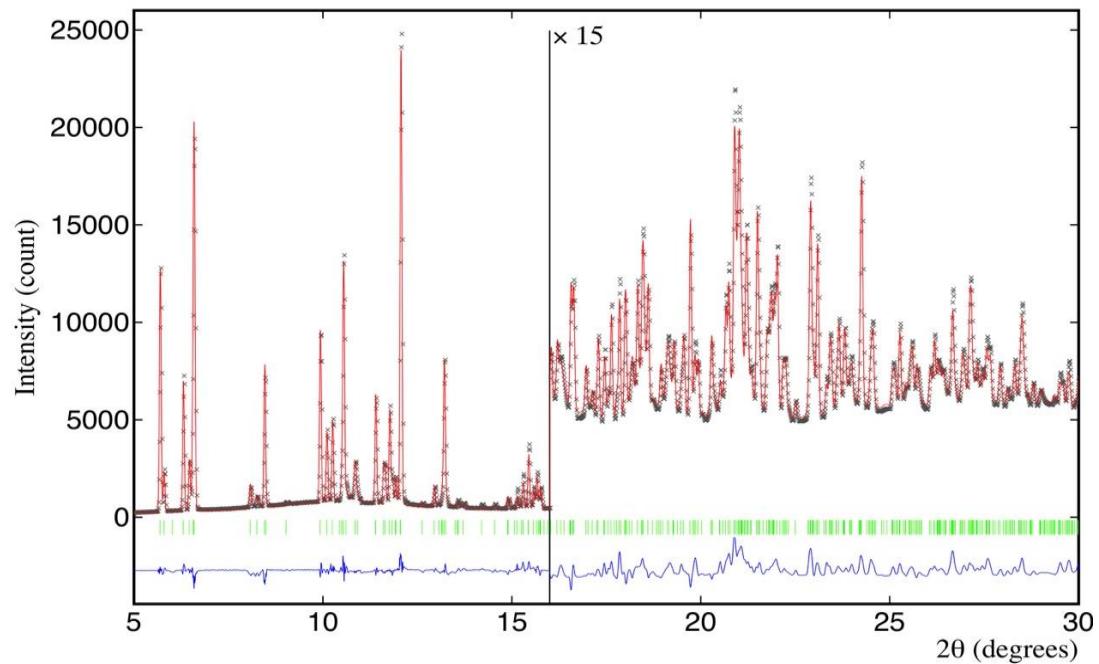
# MCX and EXPO?



# MCX and EXPO?



M Ibrahim et al., Future Medicinal Chemistry, 10, 2507 (2018)



Chemical formula	$C_{15}H_{16}SN_4$
a, b, c (Å)	14.1186(5), 7.9535(2), 13.3615(7)
b (°)	92.8285(2)
V (Å <sup>3</sup> )	1498.58
Z	4
Space group / system	C2 / Monoclinic
Radiation type	Synchrotron, $\lambda = 0.7 \text{ \AA}$
2q values (°)	$2q_{\min} = 5^\circ, 2q_{\max} = 30^\circ, 2q_{\text{step}} = 0.01^\circ$
$R_{wp}, R_p, R_{\text{exp}}, S$	0.0655, 0.0455, 0.0338, 1.937
No. of data peaks/parameters	356/45



## General info

- Deadline for proposals every six months: March 15<sup>th</sup> and September 15<sup>th</sup>
- For more info visit our website:
  - [www.elettra.eu/elettra-beamlines/mcx.html](http://www.elettra.eu/elettra-beamlines/mcx.html)
- Contact us!
  - [jasper.plaisier@elettra.eu](mailto:jasper.plaisier@elettra.eu)
  - [lara.gigli@elettra.eu](mailto:lara.gigli@elettra.eu)
  - [mattia.gaboardi@elettra.eu](mailto:mattia.gaboardi@elettra.eu)



Elettra  
Sincrotrone  
Trieste



[www.elettra.eu](http://www.elettra.eu)